PW PACKAGE (TOP VIEW)

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- 400-MHz Differential Clock Source for Direct Rambus Memory Systems for an 800-MHz Data Transfer Rate
- Operates From Two (3.3-V and 1.80-V) Power Supplies With 180 mW (Typ) at 400 MHz Total
- Packaged in a Thin Shrink Small-Outline Package (PW)
- External Crystal Required for Input

V_{DDP} 16 10 1 S0 GNDP 🗖 2 15 XOUT 🗖 3 14 ⊐ GND 13 4 🗖 CLK V_{DDL} 🗖 5 12 🗖 СГКВ 6 11 🖵 GND II V_{DD} 10 GNDL 7 8 9 S1 □ 🗖 S2

description

The Direct Rambus clock generator – lite (DRCG-Lite) is an independent crystal clock generator. It performs clock multiplication using PLL, sourced by an internal crystal oscillator. It provides one differential, high-speed Rambus channel compatible output pair. Also, one single-ended output is available to deliver 1/2 of the crystal frequency. The Rambus channel operates at up to 400 MHz with an option to select 300 MHz as well. The desired crystal is a 18.75-MHz crystal in a series resonance fundamental application.

The CDCR61A is characterized for operation over free-air temperatures of 0°C to 85°C.

functional block diagram



VDDP	S1	S2	MODE	CLK	CLKB	LCLK
ON	0	0	Normal	CLK CLKB		XIN divided by 2
ON	1	1	Normal	CLK	CLKB	XIN divided by 2
ON	0	1	Test	Divided by 2	Divided by 2	XIN divided by 2
ON	1	0	Test	Divided by 4	Divided by 4	XIN divided by 2
0 V	0	0	Test	XIN	XIN (invert)	XIN divided by 2
0 V	1	1	Test	XIN	XIN (invert)	XIN divided by 2
0 V	0	1	Test	XIN divided by 2	XIN (invert) divided by 2	XIN divided by 2
0 V	1	0	Test	XIN divided by 4	XIN (invert) divided by 4	XIN divided by 2



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TERMINAL		1/0	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
CLK	13	0	Output clock, connect to Rambus channel
CLKB	12	0	Output clock (complement), connect to Rambus channel
GNDP, GNDL, GND	2, 7, 11, 14		Ground
LCLK	6	0	LVCMOS output, 1/2 of crystal frequency
S0, S1, S2	16, 8, 9	Ι	LVTTL level logic select terminal for function selection
V _{DD}	10, 15		Power supply, 3.3 V
VDDP	1		Power supply for PLL, 3.3 V (0 V for Test mode)
VDDL	5		Power supply for LCLK, 1.8 V
XIN	4	I	Reference crystal input
XOUT	3	0	Reference crystal feedback

Terminal Functions

absolute maximum ratings over operating free-air temperature (unless otherwise noted)[†]

Supply voltage range, V _{DD} or V _{DDP} (see Note 1)	
Supply voltage range, V _{DDL} (see Note 1)	
Input voltage range, VI, at any input terminal	–0.5 V to V _{DD} + 0.5 V
Output voltage range, VO, at any output terminal (CLK, CLKB)	–0.5 V to V _{DD} + 0.5 V
Output voltage range, V _O , at any output terminal (LCLK)	
ESD rating (MIL-STD 883C, Method 3015)	> 2 kV, Machine Model >200 V
Continuous total power dissipation	see Dissipation Rating Table
Operating free-air temperature range, T _A	0°C to 85°C
Storage temperature range, T _{stg}	
Lead temperature 1,6 mm $(1/16)$ inch) from case for 10 seconds	260°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the GND terminals.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 85°C
	POWER RATING	ABOVE T _A = 25°C‡	POWER RATING
PW	1400 mW	11 mW/°C	740 mW

[‡] This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.



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recommended operating conditions

		MIN	NOM	MAX	UNIT		
Supply voltage, V _{DD}	3	3.3	3.6	V			
LCLK supply voltage, VDDL		1.7	1.8	2.1	V		
	S0			0.35×V _{DD}	V		
	S1, S2			0.35×V _{DD}	v		
	S0	0.65×V _{DD}			V		
yh-level input voltage, V _{IH} ernal pullup resistance	S1, S2	0.65×V _{DD}			v		
	S0	10	55	100	kΩ		
	S1, S2	90	145	250			
	CLK, CLKB			16	س ۸		
	LCLK			10	ША		
	CLK, CLKB			-16	A		
$\begin{array}{c c c c c c c c } & S0 & 0.65 \times V_{DD} \\ \hline S1, S2 & 0.65 \times V_{DD} \\ \hline S1, S2 & 0.65 \times V_{DD} \\ \hline S0 & 10 & 55 & 100 \\ \hline S1, S2 & 90 & 145 & 250 \\ \hline S1, S2 & 140 & 140 \\ \hline S1, S2 & 140 & 140 \\ \hline $	ША						
Input frequency at crystal input		14.0625	18.75		MHz		
	S0, S1, S2			2.5			
Input capacitance (CMOS), C	XIN, XOUT			20	рг		
Operating free-air temperature, T _A		0		85	°C		

 † Capacitance measured at f = 1 MHz, dc bias = 0.9 V, and V_{AC} < 100 mV

timing requirements

	MIN	MAX	UNIT
Clock cycle time, t _(cycle)	2.5	3.7	ns
Input slew rate, SR	0.5	4	V/ns
State transition latency (V _{DDX} or S0 to CLKs – normal mode), t _(STL)		3	ms

crystal specifications

	MIN	MAX	UNIT
Frequency	14.0625	18.75	MHz
Frequency tolerance (at 25°C ±3°C)	-15	15	ppm
Equivalent resistance (C _L = 10 pF)		100	Ω
Temperature drift (-10°C to 75°C)		10	ppm
Drive level	0.01	1500	μW
Motional inductance	20.7	25.3	mH
Insulation resistance	500		MΩ
Spurious attenuation ratio (at frequency \pm 500 kHz)	3		dB
Overtone spurious	8		dB



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CON	DITIONS [†]	MIN	TYP [‡]	MAX	UNIT
V _{O(X)}	Differential crossing-point o	See Figures 1 and 7	See Figures 1 and 7			1.85	V	
V _{O(PP)}	Peak-to-peak output voltage swing, single ended ${\sf V}$		V _{OH} – V _{OL} ,	See Figure 1	0.4		0.7	V
VIK	Input clamp voltage		V _{DD} = 3 V,	lj = -18 mA			-1.2	V
Rl	Input resistance	XIN, XOUT	V _{DD} = 3.3 V,	$V_I = V_O$		>50		kΩ
		XOUT	V _{DD} = 3.3 V,	$V_{O} = 2 V$			27	mA
IIН	High-level input current	S0	V _{DD} = 3.6 V,	$V_I = V_{DD}$			10	
		S1, S2	V _{DD} = 3.6 V,	$V_I = V_{DD}$			10	μΑ
		XOUT	V _{DD} = 3.3 V,	VO = 0 V			-5.7	mA
Ι _{ΙL}	Low-level input current	S0	V _{DD} = 3.6 V,	V _I = 0 V	-30		-100	
		S1, S2	V _{DD} = 3.6 V,	V _I = 0 V	-10		-50	μΑ
			See Figure 1				2.1	
Maria		CLK, CLKB	V _{DD} = min to max,	I _{OH} = -1 mA	V _{DD} - 0.1 V			v
⊻ОН	High-level output voltage		V _{DD} = 3 V,	I _{OH} = -16 mA	2.2			
		LCLK	V _{DDL} = min to max,	I _{OH} = - 10 mA	V _{DDL} - 0.45 V		V _{DDL}	
			See Figure 1		1			
		CLK, CLKB	V _{DD} = min to max,	I _{OL} = 1 mA			0.1	v
VOL	Low-level output voltage		V _{DD} = 3 V,	I _{OL} = 16 mA			0.5	
		LCLK	V _{DDL} = min to max,	I _{OL} = 10 mA	0		0.45	
			V _{DD} = 3.135 V,	$V_{O} = 1 V$	-32	-52		
		CLK, CLKB	V _{DD} = 3.3 V,	V _O = 1.65 V		-51		
lou	High lovel output current		V _{DD} = 3.465 V,	V _O = 3.135 V		-14.5	-21	
OH	r ligh-level output current		V _{DDL} = 1.7 V,	$V_{O} = 0.5 V$	-11	-26		
		LCLK	V _{DDL} = 1.8 V,	$V_{O} = 0.9 V$		-28		
			V _{DDL} = 2.1 V,	V _O = 1.6 V		-24.5	-35	
			V _{DD} = 3.135 V,	V _O = 1.95 V	43	61.5		
		CLK, CLKB	V _{DD} = 3.3 V,	V _O = 1.65 V		65		
	low-level output current		V _{DD} = 3.465 V,	$V_{O} = 0.4 V$		25.5	36	mΔ
OL			V _{DDL} = 1.7 V,	V _O = 1.2 V	11	27		
		LCLK	V _{DDL} = 1.8 V,	$V_{O} = 0.9 V$		30		
			V _{DDL} = 2.1 V,	$V_{O} = 0.5 V$		28	38	
rон	High-level dynamic output r	esistance§	ΔI_{O} – 14.5 mA to ΔI_{O}	– 16.5 mA	12	25	40	Ω
rol	Low-level dynamic output re	esistance§	ΔI_{O} + 14.5 mA to ΔI_{O}	+ 16.5 mA	12	17	40	Ω
Co		CLK, CLKB					3	рF
	Output capacitance	LCLK					3	ΡΓ

[†] V_{DD} refers to any of the following; V_{DD}, V_{DDL}, and V_{DDP} [‡] All typical values are at V_{DD} = 3.3 V, V_{DDL} = 1.8 V, T_A = 25°C. § $r_O = \Delta V_O / \Delta I_O$. This is defined at the output terminals, not at the measurement point of Figure 1.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

	PARAMETER	TEST CONDITIONS [†]	MIN	TYP‡	MAX	UNIT
IDD	Static supply current	Outputs high or low ($V_{DDP} = 0 V$)			6.5	mA
IDDL	Static supply current (LVCMOS)	Outputs high or low ($V_{DDP} = 0 V$)			50	μA
IDD(NORMAL)	Supply surrent in normal state	300 MHz			39	mA
	Supply current in normal state	400 MHz			50	mA
IDDL(NORMAL)	Supply current in normal state (LVCMOS)	400 MHz			8	mA

 † V_{DD} refers to any of the following; V_{DD}, V_{DDL}, and V_{DDP}

[‡] All typical values are at $V_{DD} = 3.3 \text{ V}$, $V_{DDL} = 1.8 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	ΤΥΡ [†] ΜΑΧ	UNIT	
t(cycle)	Clock cycle time (CLK, CLKB)			2.5	3.7	ns	
. .	Total jitter over 1, 2, 3, 4, 5, or 6	300 MHz	See Figure 2		140		
ĽCj	clock cycles‡	400 MHz	See Figure 3		100	ps	
4	Long torm litter	300 MHz	See Figure 4		400		
ΥĽ	Long-term jitter	400 MHz	See Figure 4		300	ps	
^t DC	Output duty cycle over 10,000 cycles		See Figure 5	45%	55%		
4		300 MHz			70		
^I DC,ERR	Output cycle-to-cycle duty cycle error	400 MHz	See Figure 6		55	ps	
t _r , t _f	Output rise and fall times (measured at 20%-80% of output voltage) [#]	CLK, CLKB	See Figure 9,	160	400	ps	
Δt	Difference between rise and fall times device (20%–80%) $ t_f - t_f ^{\#}$	See Figure 9,		100	ps		
^t c(LCLK)	Clock cycle time (LCLK)			106.6	142.2	ns	
t _(ci)	LCLK cycle jitter§		See Figure 11	-0.2	0.2	ns	
^t (cj10)	LCLK 10-cycle jitter§¶		See Figure 11	-1.3 t _(cj)	1.3 t _(cj)	ns	
tDC	Output duty cycle	LCLK		40%	60%		
t _r , t _f	Output rise and fall times (measured at 20%-80% of output voltage)	LCLK	See Figure 9		1	ns	
	DI L Joon hondwidth				-3		
			f _{mod} = 8 MHz	-20			

[†] All typical values are at $V_{DD} = 3.3$ V, $T_A = 25^{\circ}$ C.

[‡]Output short-term jitter specification is peak-to-peak (see Figure 9).

§ LCLK cycle jitter and 10-cycle jitter are defined as the difference between the measured period and the nominal period.

ILCLK 10-cycle jitter specification is based on the measured value of LCLK cycle jitter.

[#]V_{DD}= 3.3 V



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PARAMETER MEASUREMENT INFORMATION

NOTE A: These capacitors represent parasitic capacitance. No discrete capacitors are used on the test board during device characterization.





Cycle-to-cycle jitter = $|t_{C1} - t_{C2}|$ over 10000 consecutive cycles

Figure 2. Cycle-to-Cycle Jitter



 $t_{C(i)}$ = nominal expected time Cycle-to-cycle jitter = | $t_{C(i)} - t_{C(i+1)}$ | over 10000 consecutive cycles

Figure 3. Short-Term Cycle-to-Cycle Jitter over 2, 3, 4, or 6 Cycles



t_{jL} = | t_(cycle), max⁻ t_(cycle), min| over 10000 consecutive cycles

Figure 4. Long-Term Jitter



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Figure 8. LCLK Test Load Circuit and Voltage Waveform for CLK/CLKB and LCLK



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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
				_			(6)	.,			
CDCR61APW	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKR61A	Samples
CDCR61APWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKR61A	Samples
CDCR61APWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKR61A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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10-Dec-2020

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCR61APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCR61APWR	TSSOP	PW	16	2000	356.0	356.0	35.0

TEXAS INSTRUMENTS

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TUBE

- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CDCR61APW	PW	TSSOP	16	90	530	10.2	3600	3.5

PW0016A

PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.

^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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